

16-bit transparent D-type latch; 3-state Rev. 7 — 25 June 2024

1. General description

The 74ALVT16373 is a 16-bit D-type transparent latch with 3-state outputs. The device can be used as two 8-bit transparent latches or a single 16-bit transparent latch. The device features two latch enables (1LE and 2LE) and two output enables (1OE and 2OE), each controlling 8-bits. When nLE is HIGH, data at the inputs enter the latches. In this condition the latches are transparent, a latch output will change each time its corresponding D-input changes. When nLE is LOW the latches store the information that was present at the inputs a set-up time preceding the HIGH-to-LOW transition of nLE. A HIGH on nOE causes the outputs to assume a high-impedance OFF-state. Operation of the nOE input does not affect the state of the latches. Bus hold data inputs eliminate the need for external pull-up resistors to define unused inputs

2. Features and benefits

- Wide supply voltage range from 2.3 to 3.6 V
- Overvoltage tolerant inputs to 5.5 V
- BiCMOS high speed and output drive
- 16-bit transparent latch
- 5 V I/O compatible
- 3-state buffers
- Output capability: +64 mA/-32 mA
- Direct interface with TTL levels
- Input and output interface capability to systems at 5 V supply
- Bus-hold data inputs eliminate the need for external pull-up resistors to hold unused inputs
- Live insertion/extraction permitted
- Power-up reset
- Power-up 3-State
- No bus current loading when output is tied to 5 V bus
- I_{OFF} circuitry provides partial Power-down mode operation
- Latch-up performance exceeds 500 mA per JESD 78 Class II Level B
- ESD protection:
 - HBM: ANSI/ESDA/JEDEC JS-001 class 2 exceeds 2000 V
 - CDM: ANSI/ESDA/JEDEC JS-002 class C3 exceeds 1000 V
- Specified from -40 °C to 85 °C

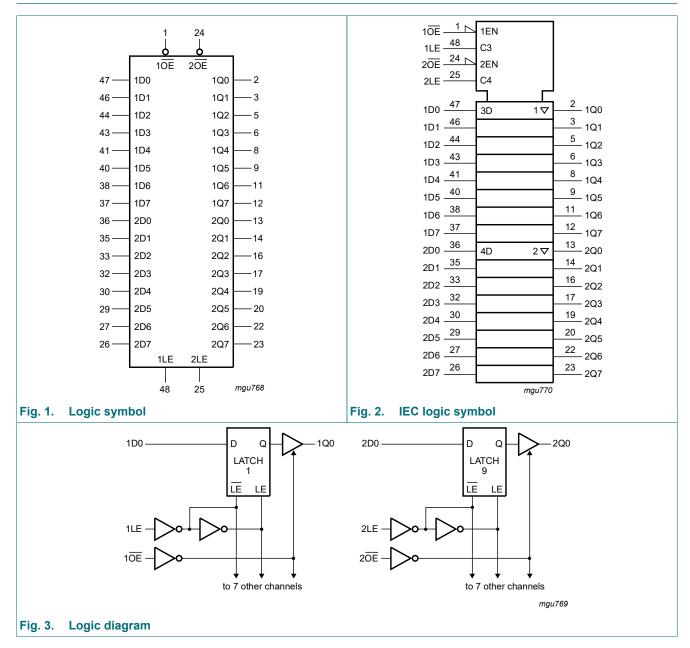
3. Ordering information

Table 1. Ordering information

Type number	Package	(age							
	Temperature range	perature range Name Description							
74ALVT16373DGG	-40 °C to +85 °C	TSSOP48	plastic thin shrink small outline package; 48 leads; body width 6.1 mm	<u>SOT362-1</u>					

nexperia

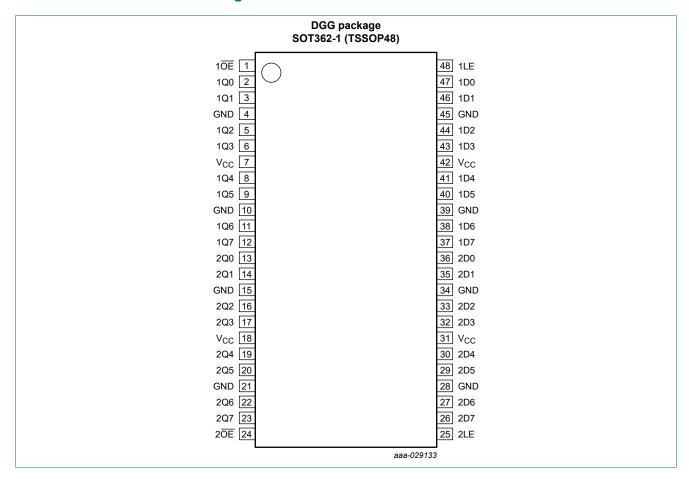
4. Functional diagram



Product data sheet

5. Pinning information

5.1. Pinning



5.2. Pin description

Table 2. Pin description		
Symbol	Pin	Description
1D0, 1D1, 1D2, 1D3, 1D4, 1D5, 1D6, 1D7	47, 46, 44, 43, 41, 40, 38, 37	data inputs
2D0, 2D1, 2D2, 2D3, 2D4, 2D5, 2D6, 2D7	36, 35, 33, 32, 30, 29, 27, 26	data inputs
1Q0, 1Q1, 1Q2, 1Q3, 1Q4, 1Q5, 1Q6, 1Q7	2, 3, 5, 6, 8, 9, 11, 12	data outputs
2Q0, 2Q1, 2Q2, 2Q3, 2Q4, 2Q5, 2Q6, 2Q7	13, 14, 16, 17, 19, 20, 22, 23	data outputs
10E, 20E	1, 24	output enable inputs (active LOW)
1LE, 2LE	48, 25	latch enable inputs (active HIGH)
GND	4, 10, 15, 21, 28, 34, 39, 45	ground (0 V)
V _{CC}	7, 18, 31, 42	supply voltage

6. Functional description

Table 3. Function table

H = HIGH voltage level; h = HIGH voltage level one set-up time prior to the HIGH-to-LOW LE transition;

L = LOW voltage level; *I* = LOW voltage level one set-up time prior to the HIGH-to-LOW LE transition;

↓ = HIGH-to-LOW LE transition;

X = don't care; NC = No change; Z = high-impedance OFF-state.

Operating mode	Inputs	Inputs			Outputs
	nOE	nLE	nDn	latches	nQn
enable and read register (transparent mode)	L	Н	L	L	L
	L	Н	Н	Н	Н
latch and read register	L	Ļ	I	L	L
	L	Ļ	h	Н	Н
Hold	L	L	Х	NC	NC
Latch register and disable outputs	Н	L	Х	NC	Z
	Н	Н	nDn	nDn	Z

7. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		Min	Max	Unit
V _{CC}	supply voltage			-0.5	+4.6	V
VI	input voltage		[1]	-0.5	+7.0	V
Vo	output voltage	output in OFF-state or HIGH-state	[1]	-0.5	+7.0	V
I _{IK}	input clamping current	V ₁ < 0 V		-50	-	mA
I _{OK}	output clamping current	V _O < 0 V		-50	-	mA
lo	output current	output in LOW-state		-	128	mA
		output in HIGH-state		-64	-	mA
T _{stg}	storage temperature			-65	+150	°C
Tj	junction temperature		[2]	-	+150	°C

[1] The input and output negative voltage ratings may be exceeded if the input and output clamp current ratings are observed.

[2] The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability.

8. Recommended operating conditions

Symbol	Parameter	Conditions	V _{CC} = 2.5	V_{CC} = 2.5 V ± 0.2 V		$V_{CC} = 3.3 V \pm 0.3 V$	
			Min	Max	Min	Max	
V _{CC}	supply voltage		2.3	2.7	3.0	3.6	V
VI	input voltage		0	5.5	0	5.5	V
I _{OH}	HIGH-level output current		-	-8	-	-32	mA
I _{OL}	LOW-level output current	none	-	8	-	32	mA
		current duty cycle \leq 50 %; f _i \geq 1 kHz	-	24	-	64	mA
Δt/ΔV	input transition rise and fall rate	outputs enabled	-	10	-	10	ns/V
T _{amb}	ambient temperature	free-air	-40	+85	-40	+85	°C

Table 5. Recommended operating conditions

9. Static characteristics

Table 6. Static characteristics

At recommended operating conditions; $T_{amb} = -40$ °C to +85 °C; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		Min	Typ <mark>[1]</mark>	Мах	Unit
V _{CC} = 2.	5 V ± 0.2 V	I					
V _{IK}	input clamping voltage	V _{CC} = 2.3 V; I _{IK} = -18 mA		-	-0.85	-1.2	V
VIH	HIGH-level input voltage			1.7	-	-	V
V _{IL}	LOW-level input voltage				-	0.7	V
V _{OH}	HIGH-level output voltage	V_{CC} = 2.3 V to 2.7 V; I _O = -100 µA		V _{CC} - 0.2	-	-	V
		V _{CC} = 2.3 V; I _O = -8 mA		1.8	-	-	V
V _{OL}	LOW-level output voltage	V _{CC} = 2.3 V; I _O = 100 μA		-	0.07	0.2	V
		V _{CC} = 2.3 V; I _O = 24 mA		-	0.3	0.5	V
V _{OL(pu)}	power-up LOW-level output voltage	V _{CC} = 2.7 V; I _O = 1 mA; V _I = V _{CC} or GND	$V_{\rm CC} = 2.7 \text{ V}; I_{\rm O} = 1 \text{ mA};$ [2]		-	0.55	V
l _l	input leakage current	all input pins	[3]				
		$V_{CC} = 0 V \text{ or } 2.7 V; V_{I} = 5.5 V$		-	0.1	10	μA
		control pins					
		V_{CC} = 2.7 V; V_{I} = V_{CC} or GND		-	0.1	±1	μA
		data pins;	[3]				
		$V_{CC} = 2.7 \text{ V}; \text{ V}_{I} = V_{CC}$		-	0.1	1	μA
		V _{CC} = 2.7 V; V _I = 0 V		-	0.1	-5	μA
I _{OFF}	power-off leakage current	$V_{CC} = 0 V; V_1 \text{ or } V_0 = 0 V \text{ to } 4.5 V$		-	0.1	±100	μA
I _{BHL}	bus hold LOW current	data inputs; V_{CC} = 2.3 V; V_{I} = 0.7 V	[4]	-	90	-	μA
I _{BHH}	bus hold HIGH current	data inputs; V_{CC} = 2.3 V; V_{I} = 1.7 V	[4]	-	-10	-	μA
I _{EX}	external current	output in HIGH-state when $V_0 > V_{CC}$; $V_0 = 5.5 V$; $V_{CC} = 2.3 V$		-	10	125	μA
I _{O(pu/pd)}	power-up/power-down output current	$V_{CC} \le 1.2 \text{ V}; V_O = 0.5 \text{ V to } V_{CC};$ V _I = GND or V _{CC} ; nOE = don't care	[5]	-	1	100	μA

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16-bit transparent D-type latch; 3-state

Symbol	Parameter	Conditions	Min	Тур <mark>[1]</mark>	Мах	Unit
I _{OZ}	OFF-state output current	V_{CC} = 2.7 V; V_{I} = V_{IL} or V_{IH}				
		output HIGH: V _O = 2.3V	-	0.5	5	μA
		output LOW: V _O = 0.5 V	-	0.5	-5	μA
I _{CC}	supply current	V_{CC} = 2.7 V; V_I = GND or V_{CC} ; I_O = 0 A				
		outputs HIGH	-	0.04	0.1	mA
		outputs LOW	-	2.3	4.5	mA
		outputs disabled [6	-	0.04	0.1	mA
ΔI _{CC}	additional supply current	per input pin; V_{CC} = 2.3 V to 2.7 V; [7 one input at V_{CC} - 0.6 V; other inputs at V_{CC} or GND	-	0.04	0.4	mA
CI	input capacitance	V _I = 0 V or V _{CC}	-	3	-	pF
Co	output capacitance	Outputs disabled; V _O = 0 V or 3 V	-	9	-	pF
V _{CC} = 3.3	3 V ± 0.3 V					_
V _{IK}	input clamping voltage	V _{CC} = 3.0 V; I _{IK} = -18 mA	-	-0.85	-1.2	V
V _{IH}	HIGH-level input voltage		2.0	-	-	V
V _{IL}	LOW-level input voltage		-	-	0.8	V
V _{OH}	HIGH-level output voltage	V _{CC} = 3.3 V ± 0.3 V; I _O = -100 μA	V _{CC} - 0.2	V _{CC}	-	V
		V _{CC} = 3.0 V; I _O = -32 mA	2.0	2.3	-	V
V _{OL}	LOW-level output voltage	V _{CC} = 3.0 V; I _O = 100 μA	-	0.07	0.2	V
		V _{CC} = 3.0 V; I _O = 16 mA	-	0.25	0.4	V
		V _{CC} = 3.0 V; I _O = 32 mA	-	0.3	0.5	V
		V _{CC} = 3.0 V; I _O = 64 mA	-	0.4	0.55	V
V _{OL(pu)}	power-up LOW-level output voltage	$V_{CC} = 3.6 \text{ V}; I_0 = 1 \text{ mA};$ [2 V ₁ = V _{CC} or GND	-	-	0.55	V
l _l	input leakage current	all input pins [3				
		V _{CC} = 0 V or 3.6 V; V _I = 5.5 V	-	0.1	10	μA
		control pins				
		V_{CC} = 3.6 V; V_{I} = V_{CC} or GND	-	0.1	±1	μA
		data pins [3				
		$V_{CC} = 3.6 V; V_{I} = V_{CC}$	-	0.5	1	μA
		$V_{CC} = 3.6 V; V_{I} = 0 V$	-	0.1	-5	μA
I _{OFF}	power-off leakage current	$V_{CC} = 0 \text{ V}; \text{ V}_{I} \text{ or } \text{ V}_{O} = 0 \text{ V to } 4.5 \text{ V}$	-	0.1	±100	μA
I _{BHL}	bus hold LOW current	data inputs; V _{CC} = 3 V; V _I = 0.8 V	75	130	-	μA
I _{BHH}	bus hold HIGH current	data inputs; V _{CC} = 3 V; V _I = 2.0 V	-75	-140	-	μA
I _{BHLO}	bus hold LOW overdrive current	data inputs; V_{CC} = 3.6 V; [8 V _I = 0 V to 3.6 V	500	-	-	μA
I _{BHHO}	bus hold HIGH overdrive current	data inputs; V_{CC} = 3.6 V; [8 V _I = 0 V to 3.6 V	-500	-	-	μA
I _{EX}	external current	output in HIGH-state when $V_O > V_{CC}$; $V_O = 5.5 V$; $V_{CC} = 3.0 V$	-	10	125	μA
I _{O(pu/pd)}	power-up/power-down output current	$V_{CC} \le 1.2 \text{ V}; V_O = 0.5 \text{ V to } V_{CC};$ [9] $V_1 = \text{GND or } V_{CC}; \text{ nOE} = \text{don't care}$	-	1	±100	μA
l _{oz}	OFF-state output current	V_{CC} = 3.6 V; V_{I} = V_{IL} or V_{IH}				
		output HIGH: V _O = 3.0V	-	0.5	5	μA
		output LOW: V _O = 0.5 V	-	0.5	-5	μA

16-bit transparent D-type latch; 3-state

Symbol	Parameter	Conditions	Min	Typ[1]	Max	Unit
I _{CC}	supply current	V_{CC} = 3.6 V; V_{I} = GND or V_{CC} ; I_{O} = 0 A				
		outputs HIGH	-	0.04	0.1	mA
		outputs LOW	-	3.5	5	mA
		outputs disabled [6]	-	0.05	0.1	mA
ΔI _{CC}	additional supply current	per input pin; V_{CC} = 3 V to 3.6 V; [7] one input at V_{CC} - 0.6 V; other inputs at V_{CC} or GND	-	0.04	0.4	mA
CI	input capacitance	V _I = 0 V or V _{CC}	-	3	-	pF
Co	output capacitance	output disabled; V _O = 0 V or 3 V	-	9	-	pF

[1] All typical values for V_{CC} = 2.5 V \pm 0.2 V are measured at V_{CC} = 2.5 V and T_{amb} = 25 °C.

All typical values for V_{CC} = 3.3 V \pm 0.3 V are measured at V_{CC} = 3.3 V and T_{amb} = 25 °C.

[2] For valid test results, data must not be loaded into the latches after applying power.

 $[3] \quad \text{Unused pins at } V_{\text{CC}} \text{ or } \text{GND}.$

[4] Not guaranteed.

[5] This parameter is valid for any V_{CC} between 0 V and 1.2 V with a transition time of up to 10 ms.

From V_{CC} = 1.2 V to V_{CC} = 2.5 V ± 0.2 V a transition time of 100 µs is permitted. This parameter is valid for T_{amb} = 25 °C only.

[6] I_{CC} with outputs disabled is measured with outputs pulled to V_{CC} or GND.

[7] This is the increase in supply current for each input at the specified voltage level other than V_{CC} or GND.

[8] This is the bus hold overdrive current required to force the input to the opposite logic state.

[9] This parameter is valid for any V_{CC} between 0 V and 1.2 V with a transition time of up to 10 ms.

From V_{CC} = 1.2 V to V_{CC} = 3.3 V ± 0.3 V a transition time of 100 µs is permitted. This parameter is valid for T_{amb} = 25 °C only.

10. Dynamic characteristics

Table 7. Dynamic characteristics

At recommended operating conditions; $T_{amb} = -40$ °C to +85 °C; voltages are referenced to GND (ground = 0 V); for test circuit see Fig. 8.

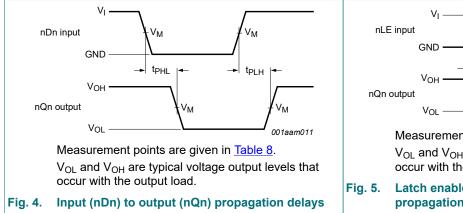
Symbol	Parameter	Conditions	Min	Typ[1]	Мах	Unit
V _{CC} = 2.	5 V ± 0.2 V			L		
t _{PLH}	LOW to HIGH propagation delay	nDn to nQn; see <u>Fig. 4</u>	1.0	2.0	3.2	ns
t _{PHL}	HIGH to LOW propagation delay	nDn to nQn; see <u>Fig. 4</u>	1.0	2.4	4.2	ns
t _{PLH}	LOW to HIGH propagation delay	nLE to nQn; see Fig. 5	1.5	2.6	4.2	ns
t _{PHL}	HIGH to LOW propagation delay	nLE to nQn; see Fig. 5	1.5	2.8	4.5	ns
t _{PZH}	OFF-state to HIGH propagation delay	n OE to nQn; see <u>Fig. 6</u>	2.0	3.5	5.5	ns
t _{PZL}	OFF-state to LOW propagation delay	n OE to nQn; see <u>Fig. 6</u>	1.5	2.6	4.7	ns
t _{PHZ}	HIGH to OFF-state propagation delay	n OE to nQn; see <u>Fig. 6</u>	1.5	2.7	4.5	ns
t _{PLZ}	LOW to OFF-state propagation delay	n OE to nQn; see <u>Fig. 6</u>	1.0	2.0	3.5	ns
t _{su(H)}	set-up time HIGH	nDn to nLE; see Fig. 7	0	-0.7	-	ns
t _{su(L)}	set-up time LOW	nDn to nLE; see <u>Fig. 7</u>	1.5	0.2	-	ns
t _{h(H)}	hold time HIGH	nDn to nLE; see Fig. 7	0.5	-0.2	-	ns
t _{h(L)}	hold time LOW	nDn to nLE; see Fig. 7	1.5	0.7	-	ns
t _{WH}	pulse width HIGH	nLE; see <u>Fig. 5</u>	1.5	-	-	ns

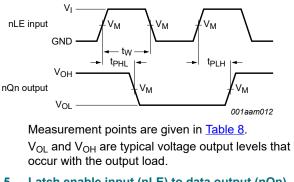
16-bit transparent D-type latch; 3-state

Symbol	Parameter	Conditions	Min	Typ[1]	Мах	Unit
V _{CC} = 3.	3 V ± 0.3 V					
t _{PLH}	LOW to HIGH propagation delay	nDn to nQn; see <u>Fig. 4</u>	0.5	1.6	2.5	ns
t _{PHL}	HIGH to LOW propagation delay	nDn to nQn; see <u>Fig. 4</u>	0.5	1.8	2.9	ns
t _{PLH}	LOW to HIGH propagation delay	nLE to nQn; see Fig. 5	1.0	2.0	3.1	ns
t _{PHL}	HIGH to LOW propagation delay	nLE to nQn; see Fig. 5	1.0	2.3	3.3	ns
t _{PZH}	OFF-state to HIGH propagation delay	n OE to nQn; see <u>Fig. 6</u>	1.5	2.3	4.0	ns
t _{PZL}	OFF-state to LOW propagation delay	n OE to nQn; see <u>Fig. 6</u>	1.0	1.9	3.1	ns
t _{PHZ}	HIGH to OFF-state propagation delay	n OE to nQn; see <u>Fig. 6</u>	1.5	2.9	4.5	ns
t _{PLZ}	LOW to OFF-state propagation delay	n OE to nQn; see <u>Fig. 6</u>	1.5	2.3	3.7	ns
t _{su(H)}	set-up time HIGH	nDn to nLE; see Fig. 7	0.5	-0.2	-	ns
t _{su(L)}	set-up time LOW	nDn to nLE; see Fig. 7	0.8	0.2	-	ns
t _{h(H)}	hold time HIGH	nDn to nLE; see Fig. 7	0.8	0	-	ns
t _{h(L)}	hold time LOW	nDn to nLE; see Fig. 7	1.0	0.2	-	ns
t _{WH}	pulse width HIGH	nLE; see <u>Fig. 5</u>	1.5	-	-	ns

[1] All typical values for V_{CC} = 2.5 V \pm 0.2 V are measured at V_{CC} = 2.5 V and T_{amb} = 25 °C. All typical values for V_{CC} = 3.3 V \pm 0.3 V are measured at V_{CC} = 3.3 V and T_{amb} = 25 °C.

10.1. Waveforms and test circuit





g. 5. Latch enable input (nLE) to data output (nQn) propagation delays and pulse width

16-bit transparent D-type latch; 3-state

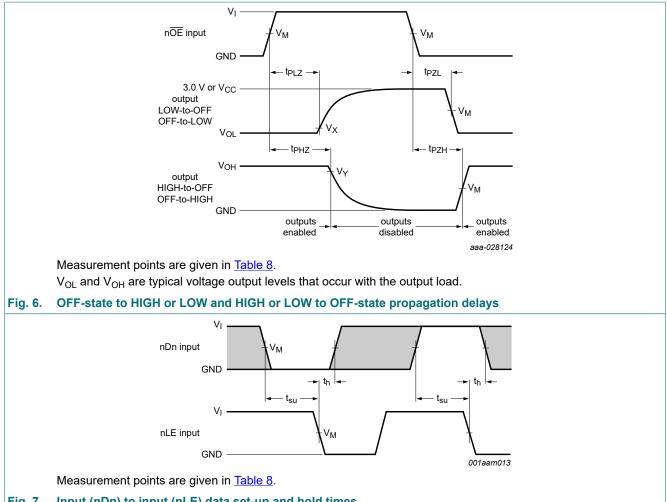


Fig. 7. Input (nDn) to input (nLE) data set-up and hold times

Table 8. Measurement points

V _{cc}	Input		Output			
	V _I V _M		V _M	V _X	V _Y	
$V_{CC} \le 2.7 V$	V _{CC}	0.5V _{CC}	0.5V _{CC}	V _{OL} + 0.15 V	V _{OH} - 0.15 V	
V _{CC} ≥ 3.0 V	3.0 V	1.5 V	1.5 V	V _{OL} + 0.3 V	V _{OH} - 0.3 V	

16-bit transparent D-type latch; 3-state

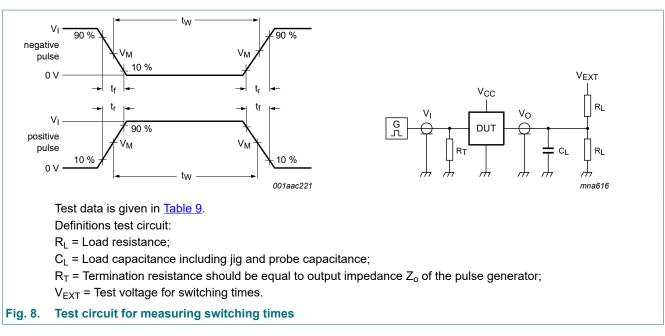


Table 9. Test data

Input			Load		V _{EXT}			
Vi	f _i	t _w	t _r , t _f	CL	RL	t _{PHZ} , t _{PZH}	t _{PLZ} , t _{PZL}	t _{PLH} , t _{PHL}
3.0 V or V_{CC} whichever is less	≤ 10 MHz	500 ns	≤ 2.5 ns	50 pF	500 Ω	GND	6 V or 2V _{CC}	open

11. Package outline

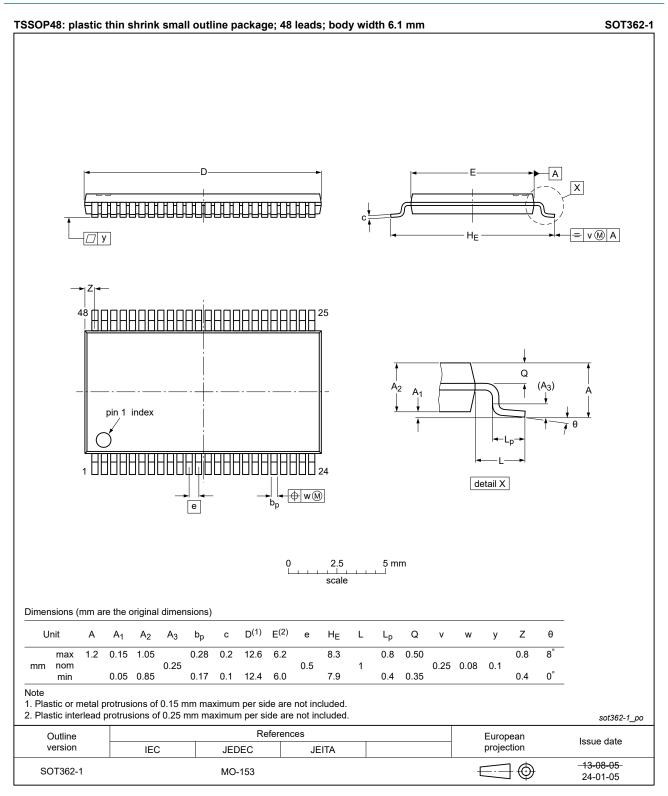


Fig. 9. Package outline SOT362-1 (TSSOP48)

12. Abbreviations

Table 10. Abbreviations				
Acronym	Description			
ANSI	American National Standards Institute			
BiCMOS	Bipolar Complementary Metal Oxide Semiconductor			
CDM	Charged Device Model			
DUT	Device Under Test			
ESD	ElectroStatic Discharge			
ESDA	ElectroStatic Discharge Association			
НВМ	Human Body Model			
JEDEC	Joint Electron Device Engineering Council			
TTL	Transistor-Transistor Logic			

13. Revision history

Table 11. Revision history						
Document ID	Release date	Data sheet status	Change notice	Supersedes		
74ALVT16373 v.7	20240625	Product data sheet	-	74ALVT16373 v.6		
Modifications:	• <u>Section 2</u> : ES	• <u>Section 2</u> : ESD specification updated according to the latest JEDEC standard.				
74ALVT16373 v.6	20240425	Product data sheet	-	74ALVT16373 v.5		
Modifications:	• <u>Fig. 9</u> : Updat	• Fig. 9: Updated package outline drawing SOT362-1 (TSSOP48).				
74ALVT16373 v.5	20210714	Product data sheet	-	74ALVT16373 v.4		
Modifications:		 <u>Section 1</u> and <u>Section 2</u> updated. Type number 74ALVT16373DL (SOT370-1/SSOP48) removed. 				
74ALVT16373 v.4	20180202	Product data sheet	-	74ALVT16373 v.3		
Modifications:	Nexperia.	The format of this data sheet has been redesigned to comply with the identity guidelines of				
74ALVT16373 v.3	19991018	Product specification	-	74ALVT16373 v.2		
74ALVT16373 v.2	19980213	Product specification	-	74ALVT16373 v.1		
74ALVT16373 v.1	19960529	Product specification	-	-		

14. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

 Please consult the most recently issued document before initiating or completing a design.

- [2] The term 'short data sheet' is explained in section "Definitions".
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the internet at <u>https://www.nexperia.com</u>.

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16-bit transparent D-type latch; 3-state

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